

Effect of Si-addition on structure and thermal stability of Ti-Al-N coatings

Zhe R. Liu^a, Fei Pei^{a,b}, Li Chen^{a,b,*}, Paul H. Mayrhofer^c

^a *State Key Laboratory of Powder Metallurgy, Central South University, Changsha 410083, China*

^b *Zhuzhou Cemented Carbide Cutting Tools Co., Ltd., Zhuzhou 412007, China*

^c *Institute of Materials Science and Technology, TU Wien, Vienna, Austria*

Abstract: The superior mechanical properties and thermal stability of Ti-Al-Si-N coatings have attracted extensive research interests in academia as well as industry. In this study, $\text{Ti}_{0.52}\text{Al}_{0.48}\text{N}$, $\text{Ti}_{0.53}\text{Al}_{0.38}\text{Si}_{0.09}\text{N}$, $\text{Ti}_{0.43}\text{Al}_{0.48}\text{Si}_{0.09}\text{N}$, and $\text{Ti}_{0.48}\text{Al}_{0.38}\text{Si}_{0.14}\text{N}$ coatings are developed by arc-evaporation. This compositional variation allows to study the impact of Al and Si on structure, thermal stability, and oxidation behavior. Incorporation of Si into Ti-Al-N leads to a nanocomposite structure with an amorphous-like SiN_x boundary-phase – encapsulating small crystalline Ti-Al-N grains – and promotes wurtzite-type AlN formation. This causes a significant change in the mechanical and thermal properties of the originally single-phase face-centered cubic structured $\text{Ti}_{0.52}\text{Al}_{0.48}\text{N}$. The Si-containing coatings experience an initial increase in hardness from 29.1 ± 1.0 GPa for $\text{Ti}_{0.52}\text{Al}_{0.48}\text{N}$ to 33.1 ± 1.2 GPa for $\text{Ti}_{0.53}\text{Al}_{0.38}\text{Si}_{0.09}\text{N}$, and then a decrease to 26.4 ± 0.8 GPa for $\text{Ti}_{0.43}\text{Al}_{0.48}\text{Si}_{0.09}\text{N}$ and 28.1 ± 0.8 GPa for $\text{Ti}_{0.48}\text{Al}_{0.38}\text{Si}_{0.14}\text{N}$. Alloying with Si improves the thermal stability of Ti-Al-N by retarding the decomposition towards its thermodynamically stable constituents TiN and AlN. Moreover, the oxidation resistance of Ti-Al-N can be largely improved by the Si-addition due to the retarded anatase-to-rutile TiO_2 transformation as well as the formation of a protective oxide scale at the nitride-to-oxide interface. Cross-sectional scanning electron microscopy studies reveal that the oxide scales of the Si-containing coatings exhibit a lamellar structure comprising Al-rich, TiSi-rich, and/or Ti-rich oxide layers. Higher Si and, especially, higher Al content is favorable to the formation of an Al-rich layer, which can act as a diffusion barrier for oxygen. Especially, all Si-containing coatings present an abnormal oxidation behavior, where the consumed nitride layer thickness is not continuously increasing with oxidation temperature.

Keywords: Coating; TiAlSiN; Thermal stability; Oxidation behavior

* Corresponding author. E-mail address: chenli_927@126.com (L. Chen)

1 **1. Introduction**

2 Hard coatings utilized as surface protection for tools and components that are employed
3 under massive mechanical and thermal loads have aroused comprehensive research interests in
4 recent decades [1]. Among them, face-centered cubic (simply abbreviated with c, NaCl-type,
5 B1) Ti-Al-N coatings play a predominant role in industrial applications due to their outstanding
6 mechanical properties, thermal stability, and especially the age-hardening ability. The latter
7 stems from thermally triggered spinodal decomposition causing the formation of coherent Al-
8 rich and even Ti-rich nitride domains, which hamper dislocation glide and motion [2-5].
9 Moreover, Ti-Al-N provides good oxidation resistance especially if a dense and protective
10 Al₂O₃-rich layer is formed on top of the coating. With increasing Al content, the typically
11 alternating Ti-rich and Al-rich oxide scale growth allows the formation of a dense and
12 protective Al₂O₃-rich outermost layer. However, for Al contents below 75% (of the metal
13 species) still a porous TiO₂-rich layer is present, which initially crystallizes with its metastable
14 anatase structure (a-TiO₂). With increasing time and/or temperature, this metastable phase
15 transforms towards its thermodynamically stable rutile structure (r-TiO₂). This transformation
16 involves a volume contraction that leads to the formation of cracks and influences also the
17 integrity of the Al₂O₃-rich top layer [6, 7]. Severe oxidation of (Ti,Al)N coatings already
18 happens when they are exposed to oxidizing environments at 850 °C [8-10], which is below the
19 requirements needed for some advanced applications, such as dry high-speed machining where
20 temperatures at the rake face or cutting edge can easily exceed 1000 °C [11].

21 To tailor the structure and improve properties, the (Ti,Al)N coatings are alloyed either with

1 other transition elements (e.g., Zr [12], Ta [13], Cr [9], V [14]), reactive elements (e.g., Ru [15],
2 La [16]), or semimetals (e.g., B [17] and Si [18]). Among them, but really special, is Si, which
3 allows to exceptionally increase both the oxidation resistance and mechanical properties
4 simultaneously. Si can substitute the elements in the c-(Ti,Al)N lattices up to a certain extent
5 but is also responsible for the formation of a nanocrystalline (nc-) respectively nanocomposite
6 structure, where nc-(Ti,Al)N grains are embedded in an amorphous-like (a-) SiN_x phase [19-
7 22]. If the interfacial a-SiN_x phase is thin, the cohesive strength of the boundaries is increased
8 leading to extremely high hardness of such alloyed (Ti,Al)N coatings [19, 21, 23]. Additionally,
9 the a-SiN_x interfacial phase can retard the decomposition of nc-(Ti,Al)N grains towards their
10 thermodynamically stable constituents TiN and AlN, thus further improving the thermal
11 stability [24, 25]. Such nc-(Ti,Al)N/a-SiN_x nanocomposite coatings remain their high hardness
12 up to 1100 °C, while the Si-free (Ti,Al)N coatings yield decomposition and softening already
13 at about 800 to 900 °C [25]. Their improved oxidation resistance can be associated with the
14 following points: The a-SiN_x interfacial phase suppresses the contact of nc-(Ti,Al)N grains with
15 oxygen by acting as a diffusion barrier [26]. Si effectively retards the phase-transition of anatase
16 TiO₂ to rutile TiO₂ and thereby reduces the crack-formation within the oxide scale [26-28]. Si
17 promotes the formation of a protective outermost Al₂O₃ layer by supporting the preferential
18 diffusion of Al to the air/oxide interface [29, 30]. Si allows to form a dense and well-adherent
19 inner oxide layer at the nitride interface [31]. However, an unsolved question arises from one
20 of our previous studies [24], where we showed that the oxide scale thickness of Ti-Al-Si-N
21 coatings is thinner after oxidizing at 1000 °C than at 950 °C.

1 To provide further evidence and explanations for this anomalous oxidation behavior, we
2 investigated Ti-Al-Si-N coatings having different Si and Al contents. $\text{Ti}_{0.52}\text{Al}_{0.48}\text{N}$,
3 $\text{Ti}_{0.53}\text{Al}_{0.38}\text{Si}_{0.09}\text{N}$, $\text{Ti}_{0.43}\text{Al}_{0.48}\text{Si}_{0.09}\text{N}$, and $\text{Ti}_{0.48}\text{Al}_{0.38}\text{Si}_{0.14}\text{N}$ coatings – arc evaporated from
4 corresponding cathodes with Si/Ti ratios of 0, 0.17, 0.21, and 0.29 and Al/(Ti+Al+Si) ratios of
5 0.48 and 0.38 in N_2 atmosphere – were investigated in detail after oxidation in synthetic air at
6 850, 900, 950 and 1000 °C for up to 15 hours. To complement the study, also hardness and
7 phase stability changes upon exposure to vacuum annealing (up to 1200 °C) are discussed.

8 **2. Experimental process**

9 *2.1 Coating preparation*

10 Ti-Al-N and Ti-Al-Si-N coatings were deposited in a commercial cathodic arc evaporation
11 system (Oerlikon Balzers, Rapid Coating System, RCS) equipped with $\text{Ti}_{0.50}\text{Al}_{0.50}$,
12 $\text{Ti}_{0.50}\text{Al}_{0.40}\text{Si}_{0.10}$, $\text{Ti}_{0.40}\text{Al}_{0.50}\text{Si}_{0.10}$, and $\text{Ti}_{0.45}\text{Al}_{0.40}\text{Si}_{0.15}$ alloyed cathodes. The vacuum chamber
13 was preheated to 500 °C and pumped to a base pressure less than 1.0×10^{-3} Pa before deposition.
14 During deposition, the process was performed in a N_2 atmosphere (99.999 % purity) at a
15 pressure of 3.2 Pa. The substrate bias and the target current were set at -40 V and 180 A,
16 respectively. Multiple substrates including cemented carbide blocks (WC-6 wt% Co, $12 \times 8 \times$
17 4 mm^3), low-alloy steel foils ($200 \times 100 \times 0.1 \text{ mm}^3$), tungsten pieces and corundum sheets (10
18 $\times 10 \times 1 \text{ mm}^3$) were chosen to meet the requirements of various measurements. All samples
19 were cleaned in ethanol and acetone using an ultrasonic cleaning machine to strengthen the
20 adhesion between substrates and coatings prior to deposition.

1 2.2 Thermal treatment

2 To acquire free-standing coating powders for the subsequent thermal treatment, the coated
3 low-alloy steel foils were immersed in 10 mol.% nitric acid to remove the substrates. Annealing
4 treatments were carried out in thermal gravimetric analysis (TGA, Netzsch-STA 409C) from
5 room temperature (RT) to specified annealing temperature (T_a) in flowing Ar (99.9% purity, 20
6 sccm flow rate) or flowing synthetic air (21% O₂, 79% N₂, 20 sccm flow rate) atmosphere. The
7 powdery samples were cooled down immediately with a cooling rate of 50 K/min after the
8 furnace was heated to a specified temperature with a heating rate of 10 K/min. The coated
9 tungsten pieces were isothermally annealed for 30 min from 800 to 1200 °C with a step of
10 100 °C in a vacuum furnace (COD533R, Germany). The annealing process was performed with
11 a pressure below 1×10^{-4} Pa and a heating rate of 5 K/min. For the coated corundum sheets, 15-
12 hour isothermal oxidation at 850, 900, 950, and 1000 °C was conducted by the aforementioned
13 TGA equipment after which fracture cross-sections were prepared to be studied by scanning
14 electron microscopy (SEM) for the oxide layers formation. For Ti_{0.48}Al_{0.38}Si_{0.14}N an additional
15 10-hour isothermal oxidation experiment was carried out.

16 2.3 Sample characterization

17 Fractured cross-sectional morphologies of oxidized coatings were obtained using a
18 scanning electron microscopy (SEM, Zeiss Supra 55) operated at 25 kV under backscattering
19 mode. The cross-sections were also investigated for the chemical variation from the outermost
20 surface down to the substrate by energy dispersive X-ray spectroscopy (EDX, Oxford
21 Instrument X-Max) line scans. Crystalline phase structures were evaluated by X-ray diffraction

1 (XRD, Bruker AXS D8 Advance) with Cu K α radiation ($\lambda = 1.541 \text{ \AA}$). The growth morphology
2 of the as-deposited coatings was studied with an aberration-corrected transmission electron
3 microscopy (TEM, FEI Titan G2 60-300 operated at 300 kV). A dual-beam focused ion beam
4 (FIB) system (FEI Helios Nanolab 600i) was utilized to prepare the TEM specimens and final
5 surface cleaning was conducted at 5 kV and 41 pA to minimize the damage induced by FIB.
6 The hardness (H) and indentation modulus of the coatings were obtained according to the Oliver
7 and Pharr method [32] using nanoindentation (Anton Paar NHT²) equipped with a Berkovich
8 diamond tip. In order to avoid the interference of substrates, a small load of 15 mN, which was
9 according to our previous experience, was managed to maintain the depth of indentation less
10 than 10% of the thickness of the coatings. At least fifteen repetitive indentations were conducted
11 for each sample to obtain their values.

12 **3. Results and discussion**

13 *3.1 Composition, structure and mechanical properties*

14 Chemical compositions of our Ti_{1-x-y}Al_xSi_yN coatings determined by EDX analysis are
15 Ti_{0.52}Al_{0.48}N, Ti_{0.53}Al_{0.38}Si_{0.09}N, Ti_{0.43}Al_{0.48}Si_{0.09}N, and Ti_{0.48}Al_{0.38}Si_{0.14}N, corresponding to the
16 targets of Ti_{0.50}Al_{0.50}, Ti_{0.50}Al_{0.40}Si_{0.10}, Ti_{0.40}Al_{0.50}Si_{0.10} and Ti_{0.45}Al_{0.40}Si_{0.15}, respectively. Here,
17 we want to mention that the notation Ti_{1-x-y}Al_xSi_yN shall not imply that Ti, Al, and Si share the
18 same metal sublattice. The notation basically gives the relative fraction of the elements Ti, Al,
19 and Si. The compositional deviation between the coatings and targets stems from gas scattering,
20 preferential resputtering of lighter Al and Si elements, and the different degrees of ionization
21 of Ti, Al, and Si during the deposition process [33]. Fig. 1 presents the XRD patterns of as-

1 deposited Ti-Al-N and Ti-Al-Si-N coatings. The structure of $\text{Ti}_{0.52}\text{Al}_{0.48}\text{N}$ can be described by
2 a well-crystallized single-phase face-centered cubic solid solution whereas all Si-containing
3 coatings exhibit a mixed cubic-wurtzite dual-phase structure. This phase transformation is
4 closely related to the amount of Al and Si in the coatings. Higher Al or Si contents promote the
5 formation of the wurtzite-type (simply abbreviated with w, ZnS-wurtzite, B4) AlN-based solid
6 solution over the cubic TiN-based solid solution [24, 28]. This phenomenon is more obvious in
7 our Al-rich $\text{Ti}_{0.43}\text{Al}_{0.48}\text{Si}_{0.09}\text{N}$ coatings and Si-rich $\text{Ti}_{0.48}\text{Al}_{0.38}\text{Si}_{0.14}\text{N}$ coatings providing a more
8 intense XRD signal at the positions close to w-AlN. Their broader diffraction peaks further
9 indicate smaller coherently diffracting domain sizes, which is caused by the competitive growth
10 of cubic and wurtzite phases. No evidence for a crystalline SiN_x phase is obtained by XRD, in
11 agreement with earlier studies of this type of coatings [19, 34].

12 Further microstructural details of the Si-containing coatings are studied by cross-sectional
13 TEM, selected area electron diffraction (SAED), and high-resolution TEM (HRTEM) of
14 $\text{Ti}_{0.48}\text{Al}_{0.38}\text{Si}_{0.14}\text{N}$ in Fig. 2. Bright-field (BF) TEM investigations reveal a featureless structure
15 (no columnar growth) with very small grain sizes. The corresponding SAED pattern, Fig. 2b,
16 shows continuous diffraction rings (typical for small grains) that can be assigned to c-Ti(Al)N
17 and w-Al(Ti)N, in excellent agreement with XRD results. HRTEM investigations (Fig. 2c)
18 reveal nanocrystals (with sizes of about 5 nm) embedded in an amorphous-like matrix, in good
19 agreement with the well-studied c-TiN/a-SiN_x nanocomposite structure [35, 36]. The coating
20 with a lower Si-content but comparable Al-fraction, $\text{Ti}_{0.53}\text{Al}_{0.38}\text{Si}_{0.09}\text{N}$, exhibits a similar
21 microstructure, which is presented in our previous study [18]. Based on our previous study on

1 $Ti_{1-x}Si_xN$ coatings – where we showed that Si can substitute for Ti up to $x \leq 0.17$ [35] – we
2 envision that also for the Ti-Al-Si-N coatings a huge fraction of Si can be incorporated in the
3 cubic phase as substitutional atom. Based on XRD and detailed TEM studies, the maximum Si
4 fraction (as a substitutional atom in $Ti_{1-x-y}Al_xSi_yN$ with $x \sim 0.38$) is slightly below $y = 0.09$.

5 The hardness of $Ti_{0.52}Al_{0.48}N$ is 29.1 ± 1.0 GPa, lower than that of $Ti_{0.53}Al_{0.38}Si_{0.09}N$ (33.1
6 ± 1.2 GPa), Fig. 3. Typically nc-(Ti,Al)N/a-SiN_x nanocomposite coatings provide a higher
7 hardness than (Ti,Al)N, due to grain refinement, increased cohesive strength of the grain
8 boundaries and hindered dislocation movement by the a-SiN_x interfacial phase [22].
9 Additionally, solid solution hardening is also active when Si atoms are at the sublattices of c-
10 (Ti,Al)N lattices as well. All these mechanisms help to increase the strength of c-(Ti,Al)N as
11 long as the fraction of the typically softer w-AlN-based phase is negligible [37], like for the
12 $Ti_{0.53}Al_{0.38}Si_{0.09}N$. Because there is a considerable amount of the typically soft w-AlN-based
13 phase in the higher Al-containing ($Ti_{0.43}Al_{0.48}Si_{0.09}N$) or higher Si-containing ($Ti_{0.48}Al_{0.38}Si_{0.14}N$)
14 coating, their hardness is with 26.4 ± 0.8 and 28.1 ± 0.8 GPa, respectively, below that of
15 $Ti_{0.52}Al_{0.48}N$. Si-addition also gives rise to a decrease in elastic modulus of Ti-Al-N coatings,
16 which can be associated with the formation of the w-AlN-based phase having lower moduli.

17 *3.2 Thermal stability*

18 The XRD patterns of (a) $Ti_{0.52}Al_{0.48}N$, (b) $Ti_{0.53}Al_{0.38}Si_{0.09}N$, (c) $Ti_{0.43}Al_{0.48}Si_{0.09}N$, and (d)
19 $Ti_{0.48}Al_{0.38}Si_{0.14}N$ powdery coatings after annealing in an inert atmosphere Ar at given
20 temperatures (T_a) are shown in Fig. 4 to describe the thermally induced structural evolution.
21 After annealing at 800 °C, the diffraction peaks of $Ti_{0.52}Al_{0.48}N$ marginally shift towards a

1 higher 2θ angle compared to the as-deposited state. This indicates rearrangement of
2 microstructural defects to lower energy sites, which thereby reduce defect density and stresses
3 within the coatings, see Fig. 4a. The shoulder peaks present at the left side of $2\theta \sim 36.7^\circ$ and
4 $\sim 42.6^\circ$ at T_a of 900°C , indicates the formation of Ti-rich cubic-structured domains pointing
5 towards a spinodal decomposition. The increased shoulder intensity and the additional
6 formation of a right shoulder of these peaks (indicative for the formation of Al-rich cubic-
7 structured domains) evidences the proceeding of spinodal decomposition in this $\text{Ti}_{0.52}\text{Al}_{0.48}\text{N}$
8 material when annealed at 1000°C . Even higher temperatures, $T_a = 1100^\circ\text{C}$, allow for the
9 formation of the thermodynamically stable w-AlN phase (see the additional peak $2\theta \sim 33.2^\circ$).
10 This progress continuously proceeds to 1300°C and is in excellent agreement to earlier studies
11 on this material system [38-41]. Further elevating the annealing temperature to 1450°C results
12 in a completed decomposition of the initially single-phase c- $\text{Ti}_{0.52}\text{Al}_{0.48}\text{N}$ into its stable
13 constituents c-TiN and w-AlN. The $\text{Ti}_{0.53}\text{Al}_{0.38}\text{Si}_{0.09}\text{N}$ coating, when compared with
14 $\text{Ti}_{0.52}\text{Al}_{0.48}\text{N}$, has its major XRD peaks – indicative for the c-TiN-based phase at smaller 2θ
15 angles, Fig. 4b. And up to $T_a = 1100^\circ\text{C}$ there are no big microstructural changes, according to
16 the similar XRD patterns, which only show a slightly increasing background in the 2θ range
17 $33\text{--}36^\circ$. For $T_a \geq 1200^\circ\text{C}$, peaks at the 2θ position for w-AlN develop while the major coating
18 peaks move towards c-TiN, indicating the formation of the stable constituents c-TiN and w-
19 AlN. After annealing at 1550°C , the additional peak at $2\theta \sim 28.4^\circ$ points towards the formation
20 of a crystalline Si phase. The higher Al or Si containing coatings, $\text{Ti}_{0.43}\text{Al}_{0.48}\text{Si}_{0.09}\text{N}$ and
21 $\text{Ti}_{0.48}\text{Al}_{0.38}\text{Si}_{0.14}\text{N}$, exhibit a comparable evolution of their microstructure with annealing

1 temperature as indicated by their XRD patterns, Figs. 4c and d, respectively. Only that the
2 formation of the more developed XRD peaks indicative for w-AlN formation is shifted to higher
3 temperatures (1300 instead of 1200 °C) for the higher Si-containing coating. Additionally, after
4 annealing at the highest temperature used (1550 °C), a crystalline alpha Si₃N₄ for higher Si-
5 containing coating can be detected, in addition to the Si phase (see Fig. 4d).

6 The microstructural changes of the Ti-Al-N and Si-alloyed Ti-Al-N coatings induce also
7 hardness changes, see Fig. 5. The hardness of Ti_{0.52}Al_{0.48}N peaks at T_a = 800 °C with 33.5 ± 0.8
8 GPa, that of Ti_{0.53}Al_{0.38}Si_{0.09}N at T_a = 1000 °C with 36.7 ± 0.7 GPa, that of Ti_{0.43}Al_{0.48}Si_{0.09}N at
9 T_a = 1000 °C with 28.1 ± 1.0 GPa, and that of Ti_{0.48}Al_{0.38}Si_{0.14}N at T_a = 1000 °C with 29.7 ±
10 0.9 GPa. As soon as a considerable fraction of w-AlN is formed, the hardness decreases. Due
11 to the different annealing procedure (the samples used for hardness measurements are
12 isothermally annealed for 30 min after reaching T_a with 5 K/min, whereas those for detailed
13 XRD investigations are immediately cooled down after reaching T_a with a heating rate of 10
14 K/min), the hardness reduction due to the formation of w-AlN is obtained at ~100 °C lower
15 temperatures than suggested by the detailed XRD investigations, Fig. 4. This has been verified
16 by XRD investigations of samples used for the hardness measurements (see supplementary
17 data). Clearly, all Si-containing coatings outperform the Ti_{0.52}Al_{0.48}N for T_a ≥ 1000 °C.

18 *3.3 Oxidation resistance*

19 Detailed XRD investigations of Ti_{0.52}Al_{0.48}N, Ti_{0.53}Al_{0.38}Si_{0.09}N, Ti_{0.43}Al_{0.48}Si_{0.09}N, and
20 Ti_{0.48}Al_{0.38}Si_{0.14}N (removed from their low-alloy steel substrates) after annealing in synthetic
21 air at 850 to 1200 °C are presented in Figs. 6a, b, c, and d, respectively (except for the

1 atmosphere, the annealing procedure is identical to that used for the vacuum annealing
2 treatment presented in Fig. 4). The oxidation products of $\text{Ti}_{0.52}\text{Al}_{0.48}\text{N}$ at $T_{\text{ox}} = 850\text{ }^{\circ}\text{C}$ are
3 dominated by anatase-structured (a-) TiO_2 next to rutile (r-) TiO_2 , see Fig. 6a. No crystalline α -
4 Al_2O_3 can be detected. After oxidizing at $T_{\text{ox}} = 950\text{ }^{\circ}\text{C}$, the peak intensities of a- TiO_2 and r-
5 TiO_2 increase and their ratio (r- TiO_2 /a- TiO_2) increases as well. A tiny diffraction peak at $\sim 35.2^{\circ}$
6 indicates the formation of corundum type α - Al_2O_3 . Increasing T_{ox} to $1000\text{ }^{\circ}\text{C}$ further promotes
7 the formation of crystalline α - Al_2O_3 as well as the anatase-to-rutile TiO_2 transformation leading
8 to decreased a- TiO_2 and increased r- TiO_2 signals. After oxidation at $T_{\text{ox}} = 1100$ and $1200\text{ }^{\circ}\text{C}$,
9 no remaining nitride phases can be detected anymore and also no a- TiO_2 ; the XRD patterns
10 basically consist of α - Al_2O_3 and r- TiO_2 contributions. Oxidizing $\text{Ti}_{0.53}\text{Al}_{0.38}\text{Si}_{0.09}\text{N}$ at $850\text{ }^{\circ}\text{C}$
11 only leads to the formation of a rather weak XRD peak at $\sim 25.3^{\circ}$, indicative for a- TiO_2 , Fig. 6b.
12 Oxidation at $T_{\text{ox}} = 950\text{ }^{\circ}\text{C}$, also lead here (corresponding to the Si-free sample, $\text{Ti}_{0.52}\text{Al}_{0.48}\text{N}$) to
13 the formation of corundum type α - Al_2O_3 and r- TiO_2 . But contrary to $\text{Ti}_{0.52}\text{Al}_{0.48}\text{N}$, still some
14 nitride phases and a- TiO_2 can be detected after oxidation at $T_{\text{ox}} = 1100\text{ }^{\circ}\text{C}$. Even after oxidation
15 at $1200\text{ }^{\circ}\text{C}$, still a- TiO_2 is present, suggesting that the Si-addition retards the anatase-to-rutile
16 transformation. The higher Al or Si containing coatings, $\text{Ti}_{0.43}\text{Al}_{0.48}\text{Si}_{0.09}\text{N}$ and
17 $\text{Ti}_{0.48}\text{Al}_{0.38}\text{Si}_{0.14}\text{N}$, exhibit no sign of crystalline oxide products after oxidizing at $850\text{ }^{\circ}\text{C}$, see
18 Figs. 6c and d, respectively. Increasing T_{ox} up to $950\text{ }^{\circ}\text{C}$, clearly a- TiO_2 , r- TiO_2 , and α - Al_2O_3
19 can be detected for both samples. Their intensity and the anatase-to-rutile ratio increase with
20 increasing T_{ox} . After oxidation at $1100\text{ }^{\circ}\text{C}$, still some nitride phases can be detected with lower
21 intensity for the higher Si-containing coating, $\text{Ti}_{0.48}\text{Al}_{0.38}\text{Si}_{0.14}\text{N}$, Fig. 6d. For both coatings a

1 considerable contribution still comes from α -TiO₂, indicating that the higher Al or Si content
2 helps to hinder the anatase-to-rutile transformation (considering that the Ti_{0.53}Al_{0.38}Si_{0.09}N
3 sample with lower Al and Si content exhibits weaker α -TiO₂ signals at the same T_{ox}). The small
4 diffraction signals marked with black arrows in Figs. 6c and d stem from an Al₂TiO₅ phase
5 formation.

6 Overall, the detailed XRD investigations after oxidation at various temperatures showed
7 that Si-addition not just retards the formation of crystalline TiO₂ but also its transformation
8 from the initially formed anatase-phase towards the thermodynamically stable rutile-phase.

9 To study the oxide scale morphology especially of the Si-containing coatings, as those for
10 Ti_{0.52}Al_{0.48}N have already been presented in Ref. [18], Ti_{0.53}Al_{0.38}Si_{0.09}N, Ti_{0.43}Al_{0.48}Si_{0.09}N, and
11 Ti_{0.48}Al_{0.38}Si_{0.14}N (on sapphire substrates) are isothermally oxidized in synthetic air for 15 h.
12 Fig. 7 shows the cross-sectional SEM and line scan images of Ti_{0.53}Al_{0.38}Si_{0.09}N after 15-hour
13 isothermal oxidation at 850 °C (a and d), 900 °C (b and e), and 950 °C (c and f). Whereas the
14 line scans indicate that all oxide scales are composed of a Ti-rich top layer, an Al-rich interlayer,
15 and a (Ti,Si)-rich sublayer (Figs. 7d, e, and f); their growth morphology is dense and
16 homogenous. The compositional variation along the oxide scale thickness is comparable to that
17 of Ti_{0.52}Al_{0.48}N [9, 10]. The oxide scales of Ti_{0.43}Al_{0.48}Si_{0.09}N grown at 850, 900, and 950 °C are
18 all much thinner than those of the lower Al-containing Ti_{0.53}Al_{0.38}Si_{0.09}N at the corresponding
19 temperature, Fig. 8. Also, the higher Si-containing coating provides a better oxidation resistance,
20 which is, however, not as improved (compared with Ti_{0.53}Al_{0.38}Si_{0.09}N) as when increasing the
21 Al content (see Fig. 9). The compositional variation along the oxide scale thickness is similar

1 for $\text{Ti}_{0.48}\text{Al}_{0.38}\text{Si}_{0.14}\text{N}$ and $\text{Ti}_{0.43}\text{Al}_{0.48}\text{Si}_{0.09}\text{N}$ with an Al-rich top layer and a (Ti,Si)-rich sublayer
2 after oxidation at 850 °C (Fig. 9a). Contrary, oxidation at higher temperatures, 900 and 950 °C,
3 led to the formation of oxide scales that are comparable between $\text{Ti}_{0.48}\text{Al}_{0.38}\text{Si}_{0.14}\text{N}$ and the
4 lower Al-containing $\text{Ti}_{0.53}\text{Al}_{0.38}\text{Si}_{0.09}\text{N}$ coating. There, a Ti-rich top layer, an Al-rich interlayer,
5 and a (Ti, Si)-rich sublayer is present, Figs. 9b and c. This compositional separation in the oxide
6 scale is related to the selective oxidation of Al due to the more negative formation energy of
7 aluminum oxide and the weaker bonding of aluminum nitride [42]. The outward diffusion of
8 Al (being faster than Ti and Si) towards the air/oxide interface and the inward diffusion of
9 oxygen towards the oxide/nitride interface cause the formation of an Al-rich oxide top layer
10 and a (Ti,Si)-rich oxide sublayer [42, 43]. A dense Al-rich oxide top layer (mainly consisting of
11 $\alpha\text{-Al}_2\text{O}_3$) is favored for excellent oxidation protection of Ti-Al-N-based coatings, as it provides
12 the best barrier to ion transport [44]. With proceeding oxidation, the anatase-structured TiO_2
13 gradually transforms towards the thermodynamically stable rutile-structured TiO_2 , which
14 involves an overall volume contraction and thereby triggers the initiation of cracks [6, 10, 44].
15 These will expand throughout the Al-rich oxide by which fast diffusion pathways for oxygen
16 are provided. We maintain that now the Si-rich regions help to “seal” the entire interface to the
17 remaining nitride by forming the inner (Ti,Si)-rich oxide layer [31].

18 The results clearly indicate that an optimized combination of Al and Si is important to
19 obtain best oxidation resistance. The thinnest oxide scale, with an intact bilayer-structure up to
20 950 °C, is provided by $\text{Ti}_{0.43}\text{Al}_{0.48}\text{Si}_{0.09}\text{N}$, which combines a high Al content with a moderate Si
21 content. This allows the formation of a dense protective Al-rich outer oxide layer and a (Ti,Si)-

1 rich inner oxide layer. The higher Si- but lower Al-containing coating, $\text{Ti}_{0.48}\text{Al}_{0.38}\text{Si}_{0.14}\text{N}$, also
2 exhibits excellent oxidation resistance as even after 15-hour isothermal oxidation at 1000 °C
3 the (originally ~3- μm -thin) coating is not fully oxidized (not shown here). Contrary, the coating
4 with the same Si- but lower Al-content, $\text{Ti}_{0.53}\text{Al}_{0.38}\text{Si}_{0.09}\text{N}$, (with respect to the best coating,
5 $\text{Ti}_{0.43}\text{Al}_{0.48}\text{Si}_{0.09}\text{N}$) is fully oxidized after a 15-hour isothermal oxidation at 1000 °C. But also this
6 one provides a much better oxidation protection than the Si-free coating, $\text{Ti}_{0.52}\text{Al}_{0.48}\text{N}$, which
7 (regardless of its higher Al-content) already completely oxidized when exposed for 10 h to air
8 at 850 °C [45]. Our XRD results presented in Fig. 6 demonstrate that the oxidation resistance
9 of $\text{Ti}_{0.52}\text{Al}_{0.48}\text{N}$ is positively influenced by Si-addition due to the prevented crystalline TiO_2
10 formation and also the retarded anatase-to-rutile transformation. Additionally, the inner (Ti,Si)-
11 rich oxide layer, which is supposed to be an admixed TiO_2 - SiO_2 oxide [46], can also protect the
12 remaining nitride because the SiO_2 is viscous (especially at higher temperatures) allowing to
13 “seal” cracks and pores [31].

14 Interestingly, the oxide scale on $\text{Ti}_{0.53}\text{Al}_{0.38}\text{Si}_{0.09}\text{N}$ is thinner for the higher oxidation
15 temperature of 900 °C ($1.12 \pm 0.10 \mu\text{m}$) than for 850 °C ($1.21 \pm 0.07 \mu\text{m}$), see Figs. 7a and
16 b. The comparison of the remaining nitride (which is also thicker for the higher T_{ox} of 900 °C)
17 shows that this behavior is not to explain with the formation of volatile oxidation products.
18 Clearly, the oxide-scale has a better protective behavior when grown at the higher oxidation
19 temperate of 900 °C. The higher Si- but same Al-containing coating, $\text{Ti}_{0.48}\text{Al}_{0.38}\text{Si}_{0.14}\text{N}$, shows a
20 comparable behavior when increasing the oxidation temperature from 900 to 950 °C, after
21 which the oxide scale is $1.87 \pm 0.15 \mu\text{m}$ and $1.62 \pm 0.11 \mu\text{m}$ thin, respectively (see Figs.

1 9b and c). Such a phenomena is not observed for Si-free Ti-Al-N [47] and not that obvious for
2 the higher Al- but same Si-containing coating, $\text{Ti}_{0.43}\text{Al}_{0.48}\text{Si}_{0.09}\text{N}$ (with respect to $\text{Ti}_{0.53}\text{Al}_{0.38}\text{Si}_{0.09}\text{N}$,
3 where this phenomena is most pronounced), which showed the thinnest oxide scales among all
4 coatings investigated for 800, 900, and 950 °C, see Fig. 8. But when investigating the remaining
5 nitride layer thickness, also this coating shows a somehow anomalous behavior, with a thicker
6 remaining nitride for $T_{\text{ox}} = 900$ than for $T_{\text{ox}} = 850$ °C, compare Figs. 8b and a, respectively.

7 Considering this important outcome, looking at the consumed nitride layer thickness in
8 more detail is necessary, Fig. 10. All three Si-containing coatings show that the consumed
9 nitride layer thickness is not continuously increasing with oxidation temperature. The lower Si
10 containing coatings, $\text{Ti}_{0.53}\text{Al}_{0.38}\text{Si}_{0.09}\text{N}$ and $\text{Ti}_{0.43}\text{Al}_{0.48}\text{Si}_{0.09}\text{N}$, show a minimum at $T_{\text{ox}} = 900$ °C,
11 whereas the higher Si-containing one, $\text{Ti}_{0.48}\text{Al}_{0.38}\text{Si}_{0.14}\text{N}$, shows that the nitride layer is less
12 consumed during oxidation at 950 °C than at 900 °C. As mentioned above, such a behavior has
13 never been observed for Si-free Ti-Al-N, clearly connecting this phenomenon to the addition of
14 Si. We envision that the Si-effect is multifold. Si is able to form a protective oxide scale at the
15 nitride-to-oxide interface, as nicely shown for Si-doped high entropy nitrides [31], and Si
16 retards the anatase-to-rutile transformation. While for Si-free Ti-Al-N there is no a-TiO₂
17 detectable anymore for $T_{\text{ox}} \geq 1100$ °C, the Si-containing coatings exhibit a-TiO₂ even after
18 oxidation at 1200 °C, see Fig. 6. Based on these XRD results a Si/Ti ratio of 0.21
19 ($\text{Ti}_{0.43}\text{Al}_{0.48}\text{Si}_{0.09}\text{N}$) seems to be most effective in retarding the a-TiO₂-to-r-TiO₂ transformation.
20 The coatings with higher Si/Ti-ratio (0.29 for $\text{Ti}_{0.48}\text{Al}_{0.38}\text{Si}_{0.14}\text{N}$) or lower ratio (0.17 for
21 $\text{Ti}_{0.53}\text{Al}_{0.38}\text{Si}_{0.09}\text{N}$) exhibit a higher rutile-to-anatase intensity ratio for $T_{\text{ox}} = 1100$ and 1200 °C. Up

1 to 1000 °C, the intensity ratio between r-TiO₂ (110, at 27.4°) and a-TiO₂ (101, at 25.3°) is still
2 below 1 for the Si-containing films, therefore these films (and especially Ti_{0.43}Al_{0.48}Si_{0.09}N, which
3 exhibits an intensity ratio of 0.39) will experience a less-pronounced a-TiO₂-to-r-TiO₂
4 connected transformation-induced volume contraction. Hence, for these oxide scales there is a
5 reduced initiation of cracks at these elevated temperatures, which promotes the formation of a
6 dense and protective outer α-Al₂O₃-based oxide scale. For the Ti-Al-Si-N coatings with a higher
7 or lower Si/Ti ratio than 0.21 (Ti_{0.53}Al_{0.38}Si_{0.09}N and Ti_{0.48}Al_{0.38}Si_{0.14}N) the outermost oxide scale is
8 already Ti-rich after the 15-h isothermal oxidation at 900 and 950 °C, Figs. 7 and 9. This is not
9 the case for Ti_{0.43}Al_{0.48}Si_{0.09}N (with a Si/Ti-ratio of 0.21), which shows the Al-rich oxide scale as
10 the top layer even after oxidation at 950 °C. Based on these results we envision that the a-TiO₂-
11 to-r-TiO₂ transformation cracks the outermost Al₂O₃-based oxide scale. Thereby, fast-diffusion
12 pathways for Ti are provided, which then forms the outermost Ti-rich oxide.

13 To further prove this scenario, the Ti_{0.48}Al_{0.38}Si_{0.14}N coating (Si/Ti ratio of 0.29) was
14 investigated after a shorter exposure (10 h) to the isothermal oxidation treatment at 850, 900,
15 and 950 °C. The corresponding cross-sectional SEM investigations, Figs. 11a, b, and c,
16 respectively, again show that the oxide scale is thinner with a thicker remaining nitride layer
17 when oxidation is conducted at 950 °C instead of 900 °C (0.87 ± 0.01, 1.75 ± 0.07, and
18 1.39 ± 0.07 μm oxide scale thickness for T_{ox} = 850, 900, and 950 °C, respectively). Now the
19 EDS line scans prove that the outermost oxide layer is Al-rich. Noticeably, as shown by the
20 local enlarged insets of Figs. 11c and b, the Al-rich oxide layer is denser when grown at 950 °C
21 than at 900 °C, respectively. The line scan signal for Ti slightly increases at the outermost region

1 of the oxide scale grown at 850, 900 and 950 °C, see Figs. 11d, e, and f, respectively, suggesting
2 that Ti atoms are about to diffuse towards the air/oxide interface. This is increasingly
3 pronounced for increasing oxidation temperature. Therefore, after 15 h the outermost oxide
4 scale is clearly Ti-rich with $T_{ox} = 900$ and 950 °C.

5 **4. Conclusions**

6 The effect of Si-addition on structure and thermal stability of arc-evaporated (Ti,Al)N
7 coatings is investigated. $Ti_{0.52}Al_{0.48}N$ exhibits a well-crystallized single-phase face-centered
8 cubic structure, whereas Si-containing $Ti_{0.53}Al_{0.38}Si_{0.09}N$, $Ti_{0.43}Al_{0.48}Si_{0.09}N$, and
9 $Ti_{0.48}Al_{0.38}Si_{0.14}N$ have a nanocomposite structure of nanometer-sized cubic and wurtzite
10 crystalline grains fully encapsulated by an amorphous-like SiN_x boundary-phase. This
11 structural evolution – from a single-phase c-(Ti,Al)N to a nc-(Ti,Al)N/a- SiN_x – results in an
12 improved hardness (from 29.1 ± 1.0 GPa for $Ti_{0.52}Al_{0.48}N$ to 33.1 ± 1.2 GPa for
13 $Ti_{0.53}Al_{0.38}Si_{0.09}N$) as long as the formation of the softer wurtzite-type phase is minor. The latter
14 is promoted by the alloying with Si, and therefore the $Ti_{0.43}Al_{0.48}Si_{0.09}N$ (higher Al than
15 $Ti_{0.53}Al_{0.38}Si_{0.09}N$) and $Ti_{0.48}Al_{0.38}Si_{0.14}N$ (higher Si than $Ti_{0.53}Al_{0.38}Si_{0.09}N$) again exhibit a
16 lower hardness of 26.4 ± 0.8 and 28.1 ± 0.8 GPa, respectively. Furthermore, the incorporation
17 of Si effectively retards the decomposition of the supersaturated (Ti,Al)N solid solution towards
18 its thermodynamically stable constituents c-TiN and w-AlN. This prolongs the age-hardening
19 effect of this type of material from 800 to 1000 °C and leads to a better performance in
20 mechanical properties especially for annealing temperatures (or application temperatures)
21 above 1000 °C.

1 Probably even more important is the enormous impact that Si applies to the oxidation
2 resistance of Ti-Al-N coatings. The results presented here clearly prove that the Si-effect is
3 multifold: The a-SiN_x interfacial phase acts as a diffusion barrier, and if TiO₂ is formed, Si
4 retards its phase-transition from anatase to rutile. This reduces the thereby connected crack-
5 formation within the oxide scale. Furthermore, Si promotes the formation of a protective
6 outermost Al₂O₃ layer (at the interface to the ambient air) and a dense, well-adherent inner
7 oxide layer (at the interface to the underlying nitride layer). The anatase-to-rutile transformation
8 largely depends on the Si/Ti ratio of the Ti-Al-Si-N coatings. The Si/Ti ratio of 0.21 for
9 Ti_{0.43}Al_{0.48}Si_{0.09}N is more effective than 0.29 for Ti_{0.48}Al_{0.38}Si_{0.14}N and 0.17 for Ti_{0.53}Al_{0.38}Si_{0.09}N to
10 retard this transformation, and therefore the Ti_{0.43}Al_{0.48}Si_{0.09}N will experience fewer crack
11 formation. This helps to keep the protective oxide scale intact and the oxidation resistance high.
12 All three Si-containing coatings present an abnormal oxidation behavior, where the consumed
13 nitride layer thickness is not continuously increasing with oxidation temperature. This is
14 because a denser and more protective Al-rich layer is formed at a higher oxidation temperature,
15 which is supported by the Si-alloying.

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21
22

1 **Figure captions**

2 Fig. 1 XRD patterns of $\text{Ti}_{0.52}\text{Al}_{0.48}\text{N}$, $\text{Ti}_{0.53}\text{Al}_{0.38}\text{Si}_{0.09}\text{N}$, $\text{Ti}_{0.43}\text{Al}_{0.48}\text{Si}_{0.09}\text{N}$, and
3 $\text{Ti}_{0.48}\text{Al}_{0.38}\text{Si}_{0.14}\text{N}$ powdery coatings in the as-deposited state.

4

5 Fig. 2 Cross-sectional TEM image (a), SAED pattern (b), and HRTEM image (c) of
6 $\text{Ti}_{0.48}\text{Al}_{0.38}\text{Si}_{0.14}\text{N}$.

7

8 Fig. 3 Indentation hardness (H) and elastic modulus of $\text{Ti}_{0.52}\text{Al}_{0.48}\text{N}$, $\text{Ti}_{0.53}\text{Al}_{0.38}\text{Si}_{0.09}\text{N}$,
9 $\text{Ti}_{0.43}\text{Al}_{0.48}\text{Si}_{0.09}\text{N}$, and $\text{Ti}_{0.48}\text{Al}_{0.38}\text{Si}_{0.14}\text{N}$ coatings deposited on cemented carbides.

10

11 Fig. 4 XRD patterns of (a) $\text{Ti}_{0.52}\text{Al}_{0.48}\text{N}$, (b) $\text{Ti}_{0.53}\text{Al}_{0.38}\text{Si}_{0.09}\text{N}$, (c) $\text{Ti}_{0.43}\text{Al}_{0.48}\text{Si}_{0.09}\text{N}$, and
12 (d) $\text{Ti}_{0.48}\text{Al}_{0.38}\text{Si}_{0.14}\text{N}$ powdery coatings after annealing in Ar at given temperatures.

13

14 Fig. 5 Indentation hardness of $\text{Ti}_{0.52}\text{Al}_{0.48}\text{N}$, $\text{Ti}_{0.53}\text{Al}_{0.38}\text{Si}_{0.09}\text{N}$, $\text{Ti}_{0.43}\text{Al}_{0.48}\text{Si}_{0.09}\text{N}$, and
15 $\text{Ti}_{0.48}\text{Al}_{0.38}\text{Si}_{0.14}\text{N}$ coatings deposited on tungsten pieces after vacuum-annealing at given
16 temperatures.

17

18 Fig. 6 XRD patterns of (a) $\text{Ti}_{0.52}\text{Al}_{0.48}\text{N}$, (b) $\text{Ti}_{0.53}\text{Al}_{0.38}\text{Si}_{0.09}\text{N}$, (c) $\text{Ti}_{0.43}\text{Al}_{0.48}\text{Si}_{0.09}\text{N}$, and
19 (d) $\text{Ti}_{0.48}\text{Al}_{0.38}\text{Si}_{0.14}\text{N}$ powdery coatings after oxidation at given temperatures.

20

21 Fig. 7 Cross-sectional SEM images (a, b, and c) and corresponding elemental maps (d, e,

1 and f) of $\text{Ti}_{0.53}\text{Al}_{0.38}\text{Si}_{0.09}\text{N}$ deposited on corundum sheets after 15-hour isothermal oxidation at
2 850 °C (a and d), 900 °C (b and e), and 950 °C (c and f).

3

4 Fig. 8 Cross-sectional SEM images (a, b, and c) and corresponding elemental maps (d, e,
5 and f) of $\text{Ti}_{0.43}\text{Al}_{0.48}\text{Si}_{0.09}\text{N}$ deposited on corundum sheets after 15-hour isothermal oxidation at
6 850 °C (a and d), 900 °C (b and e), and 950 °C (c and f).

7

8 Fig. 9 Cross-sectional SEM images (a, b, and c) and corresponding elemental maps (d, e,
9 and f) of $\text{Ti}_{0.48}\text{Al}_{0.38}\text{Si}_{0.14}\text{N}$ deposited on corundum sheets after 15-hour isothermal oxidation at
10 850 °C (a and d), 900 °C (b and e), and 950 °C (c and f).

11

12 Fig. 10 Consumed nitride thickness on $\text{Ti}_{0.52}\text{Al}_{0.48}\text{N}$, $\text{Ti}_{0.53}\text{Al}_{0.38}\text{Si}_{0.09}\text{N}$, $\text{Ti}_{0.43}\text{Al}_{0.48}\text{Si}_{0.09}\text{N}$,
13 and $\text{Ti}_{0.48}\text{Al}_{0.38}\text{Si}_{0.14}\text{N}$ coatings after 15-hour isothermal oxidation at 850, 900, and 950 °C.

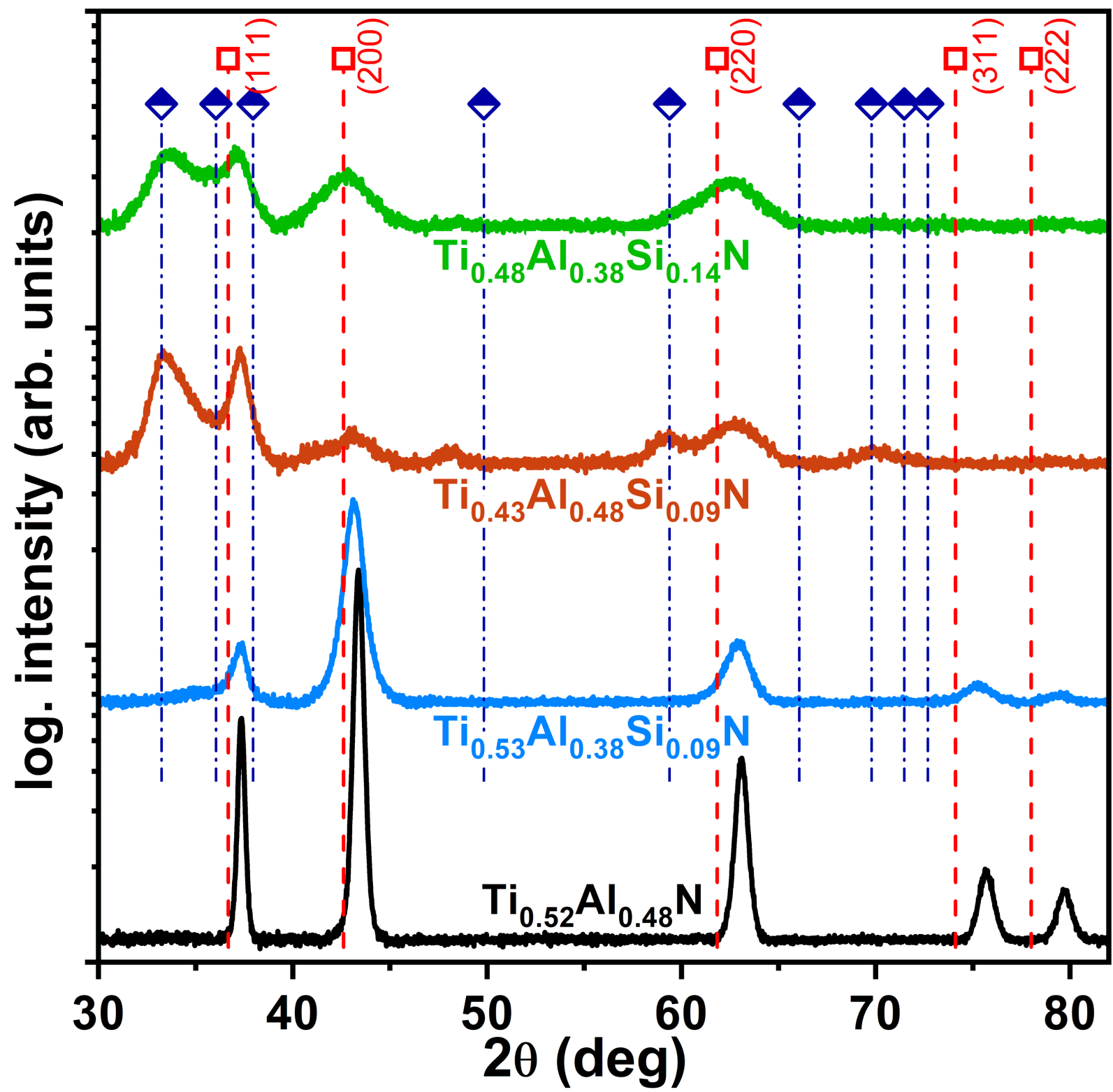
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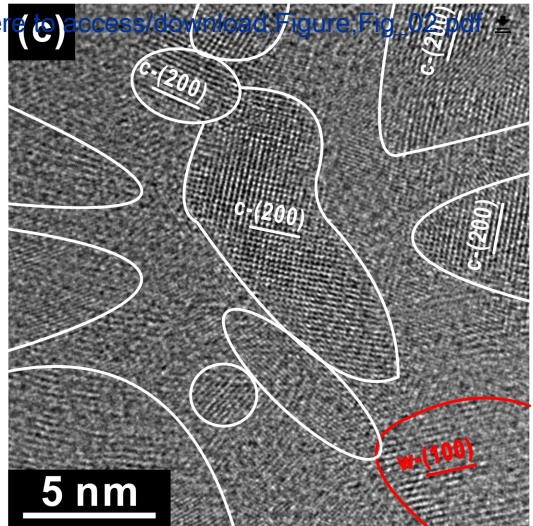
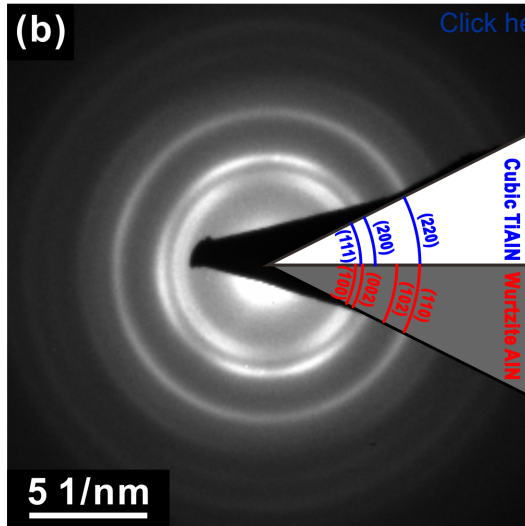
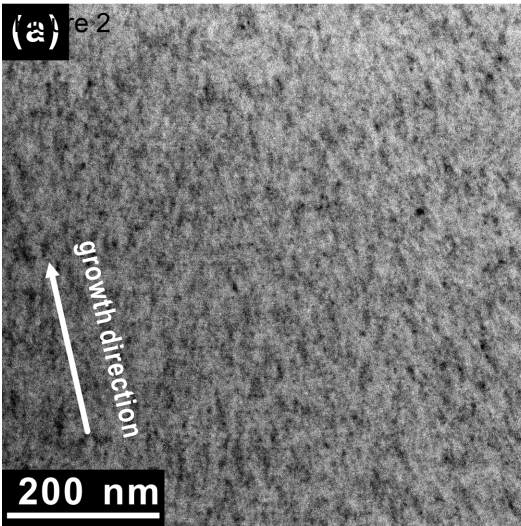
15 Fig. 11 Cross-sectional SEM images (a, b, and c) and corresponding elemental maps (d, e,
16 and f) of $\text{Ti}_{0.48}\text{Al}_{0.38}\text{Si}_{0.14}\text{N}$ after deposited on corundum sheets 10-hour isothermal oxidation at
17 850 °C (a and d), 900 °C (b and e), and 950 °C (c and f).

- Both thermal stability and oxidation resistance are enhanced after Si-alloying.
- The effect of Si on the oxidation behavior of Ti-Al-Si-N is multifold.
- The Si/Ti ratio of 0.21 retards the anatase-to-rutile transformation most.
- Si-alloying leads to an abnormal oxidation behavior of Ti-Al-N coatings.

Figure 1

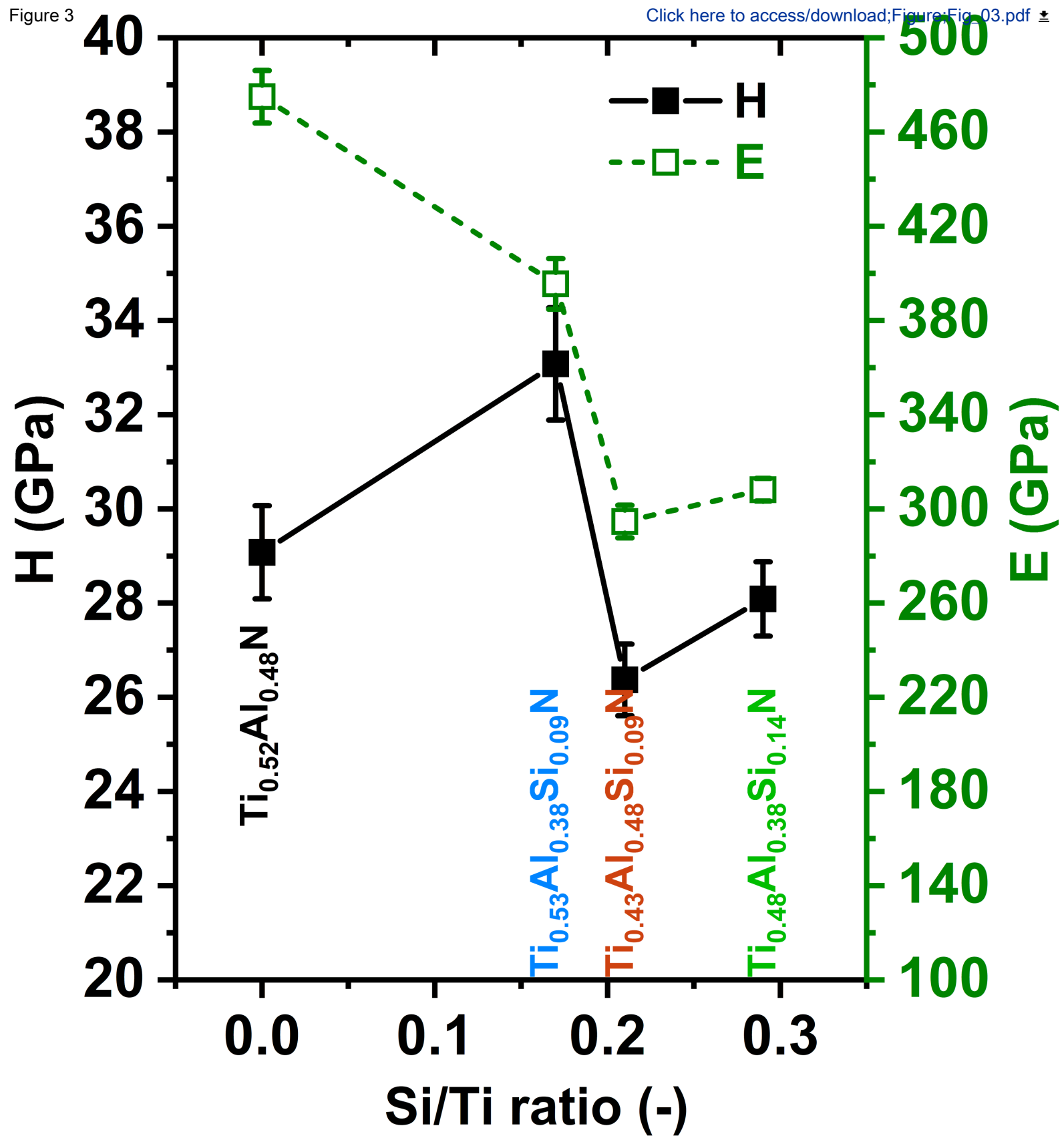
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Figure 3



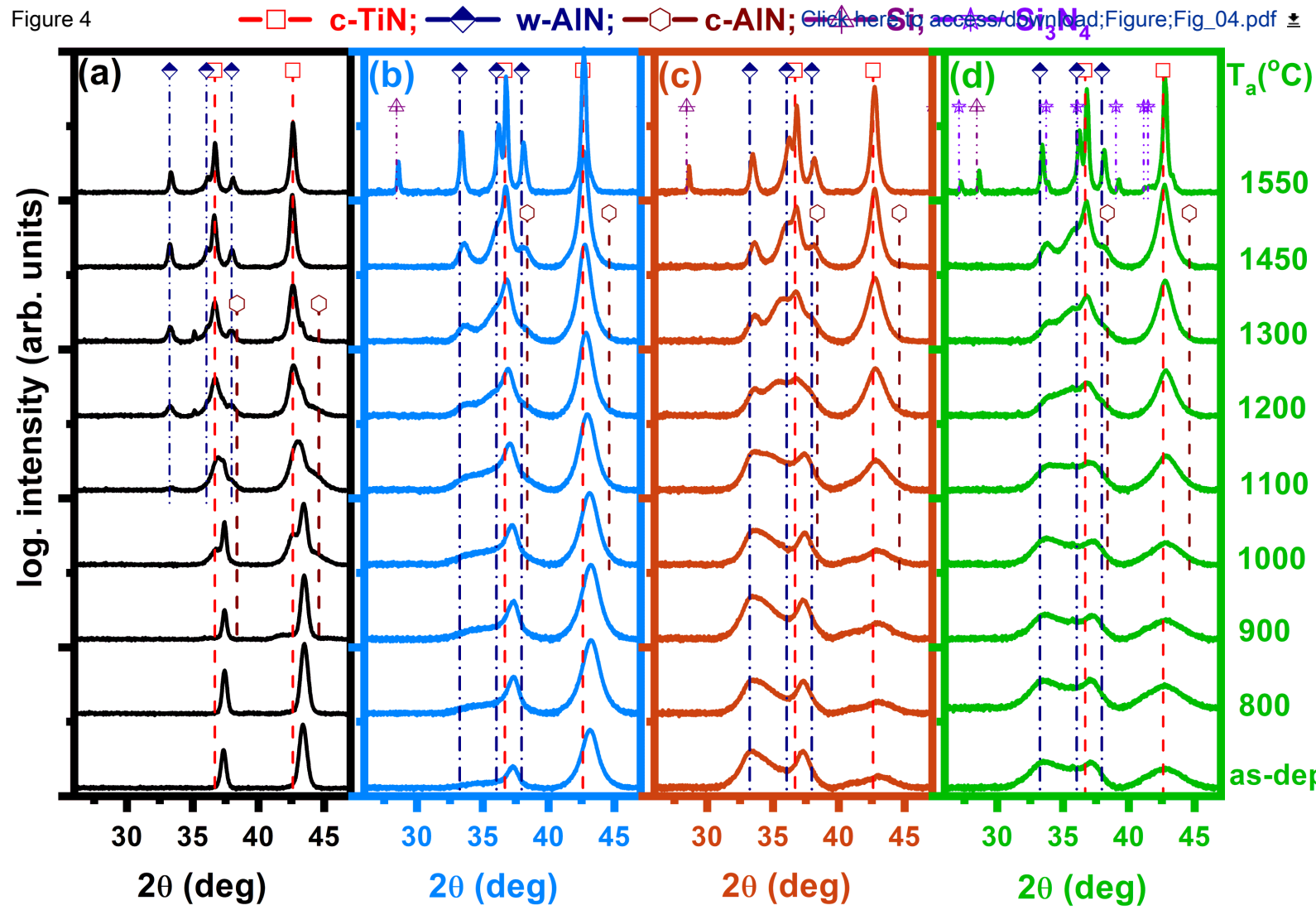


Figure 5

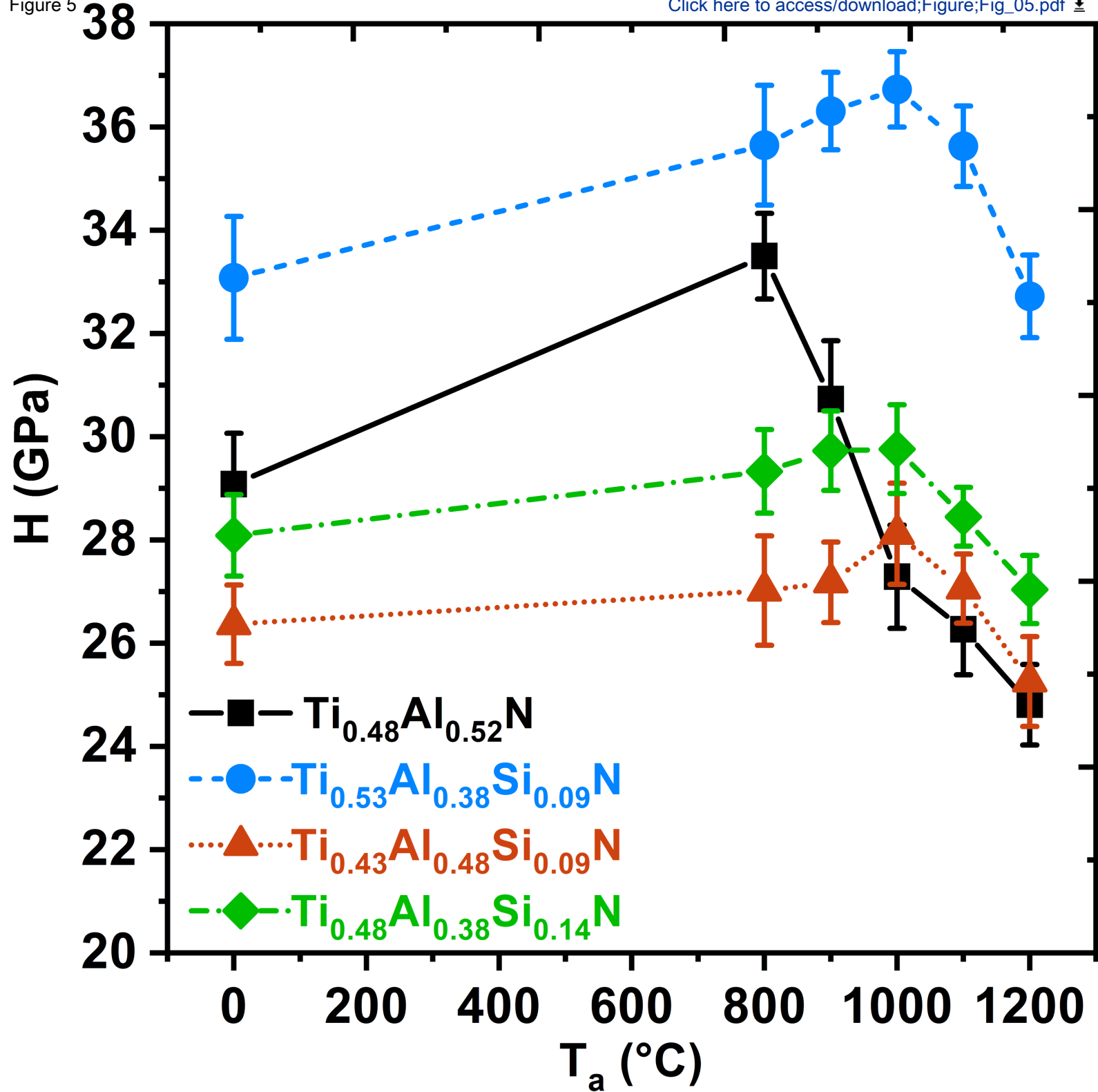
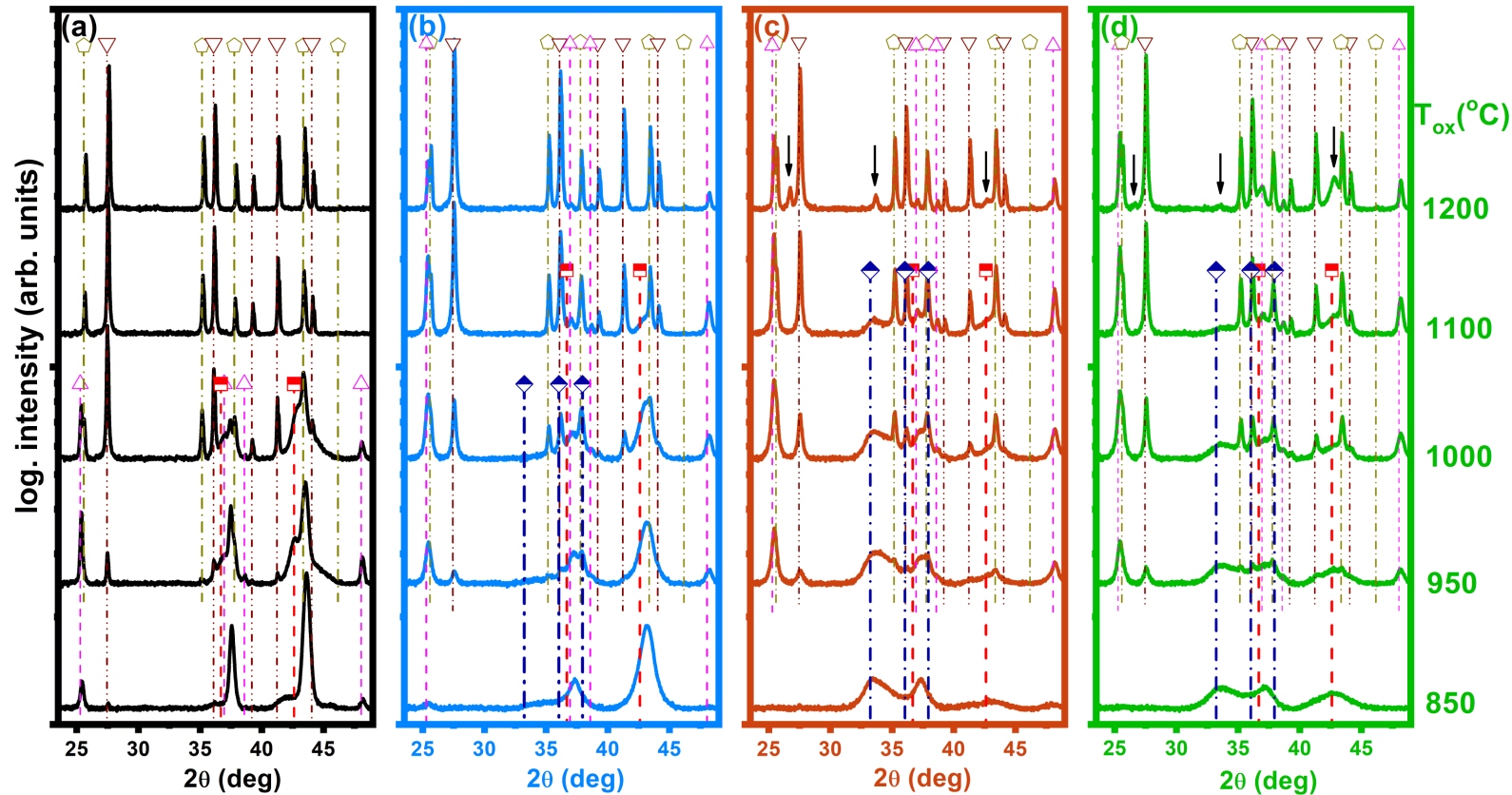
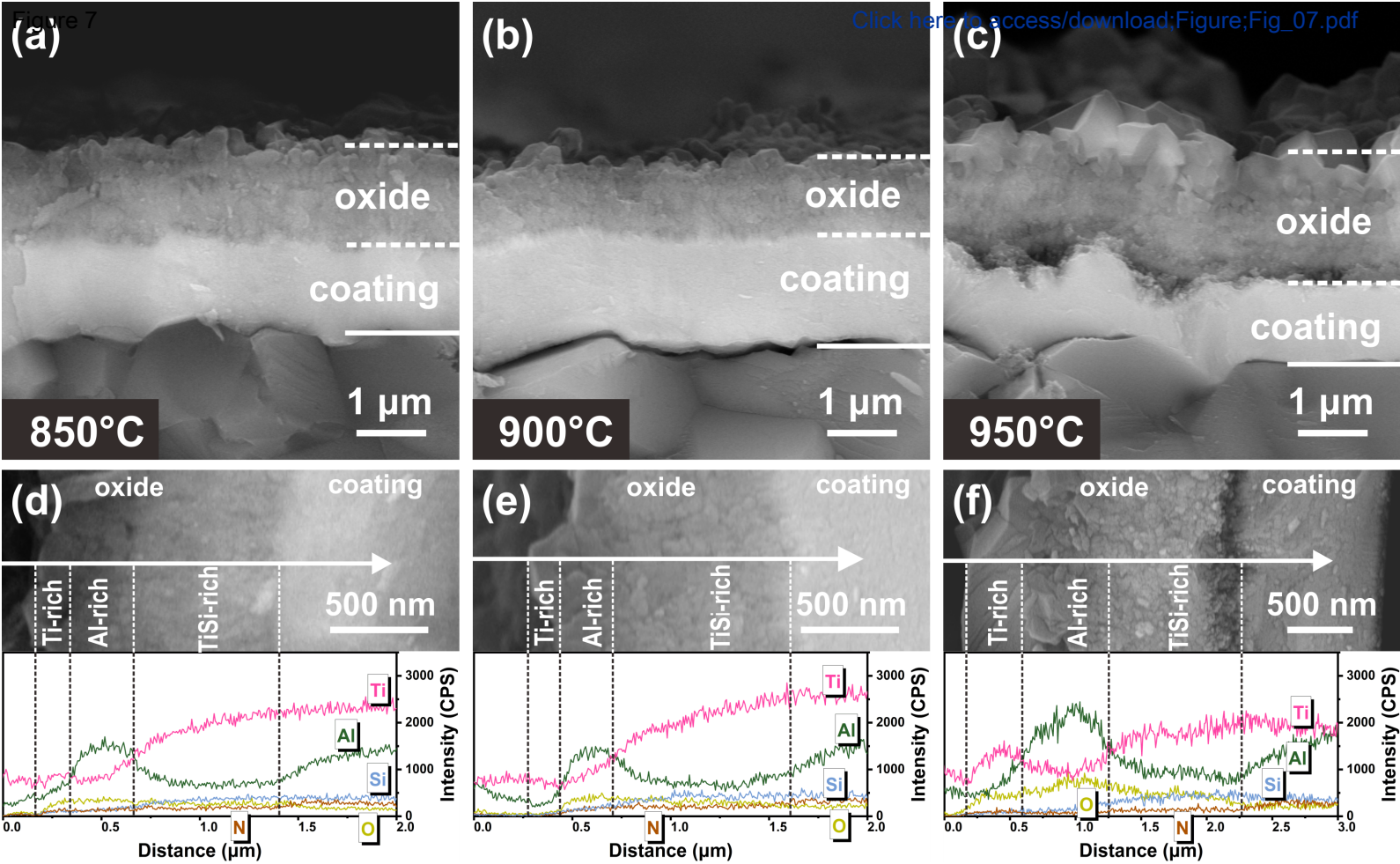
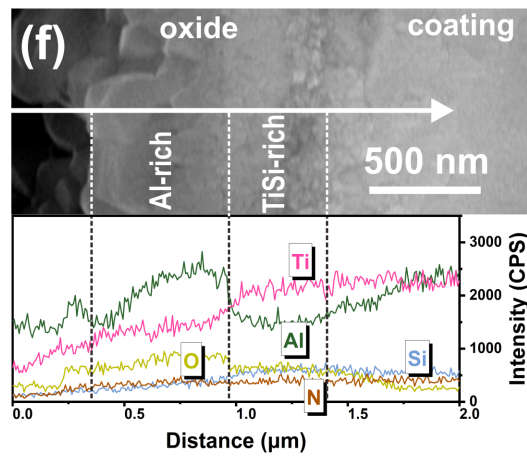
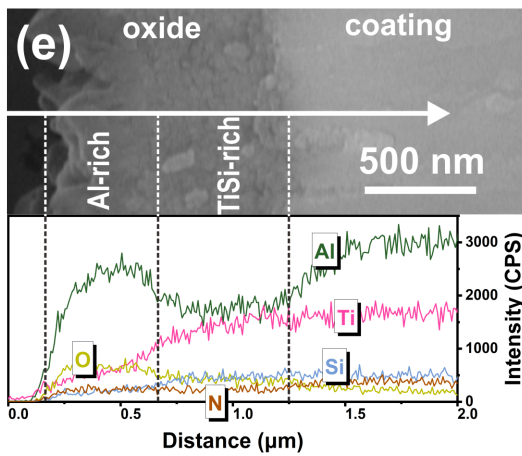
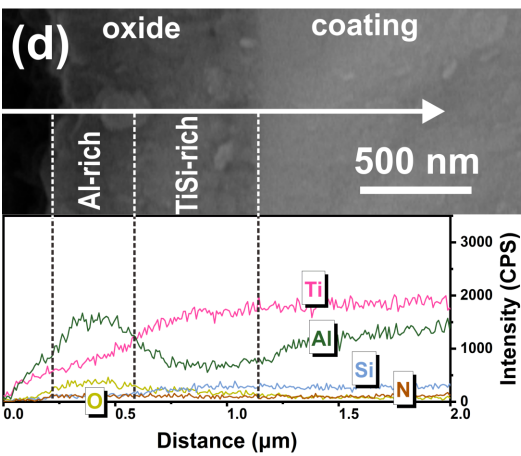
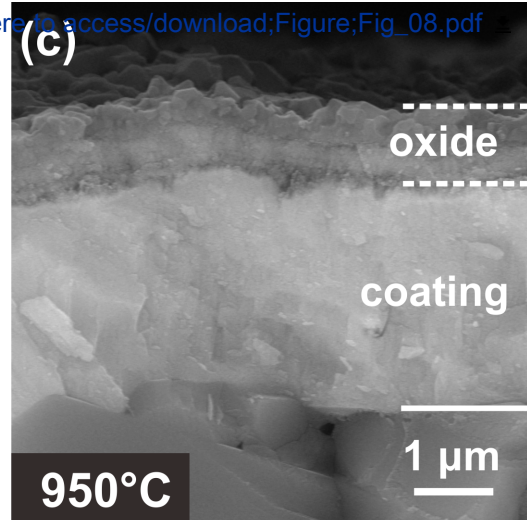
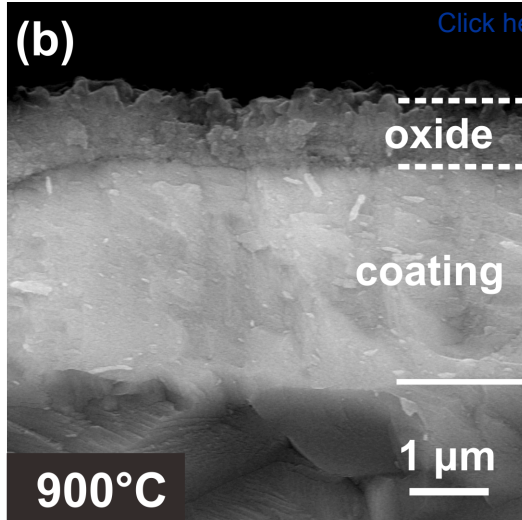
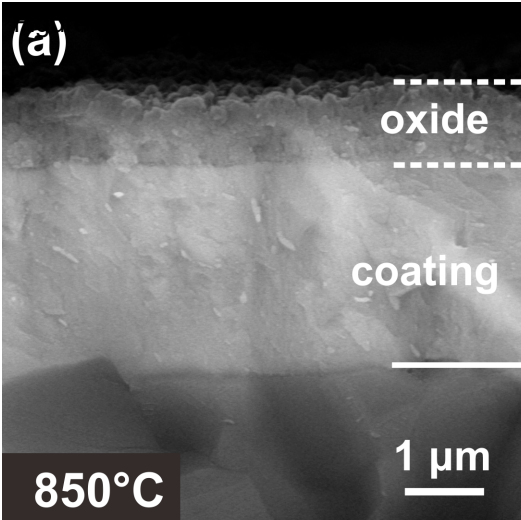


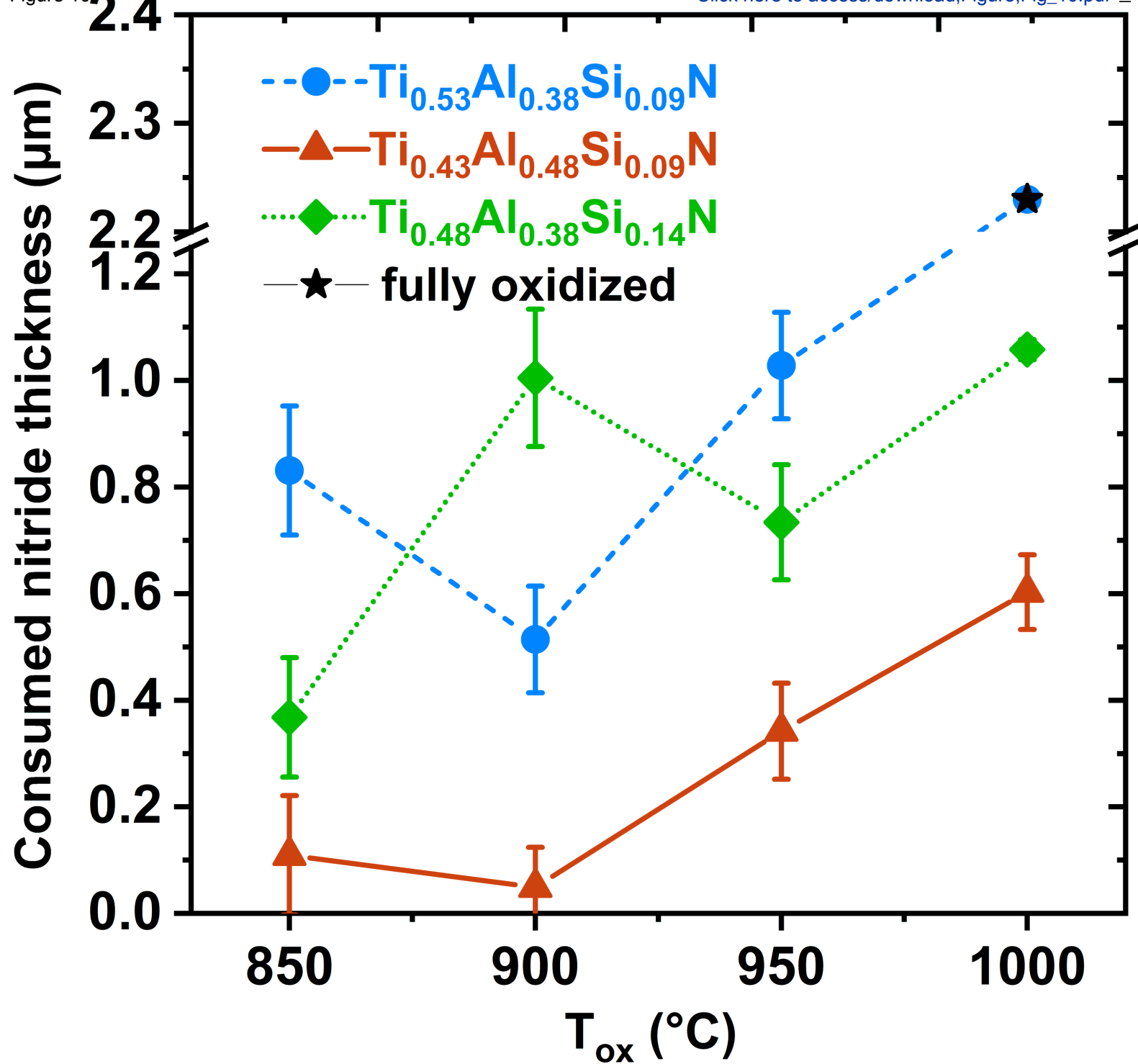
Figure 6

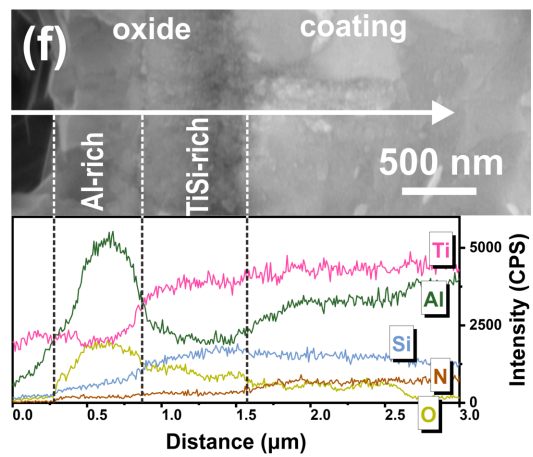
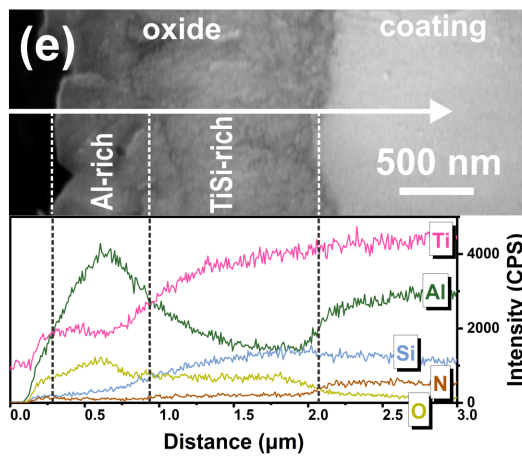
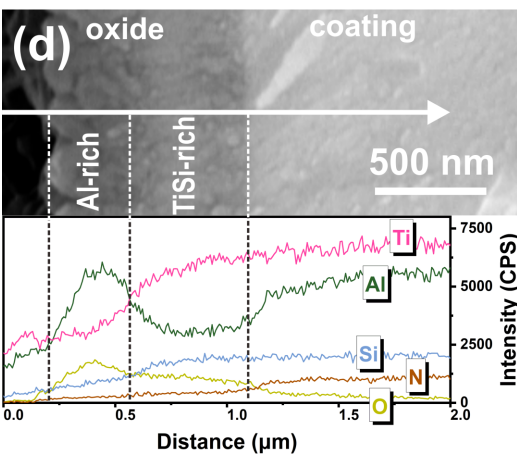
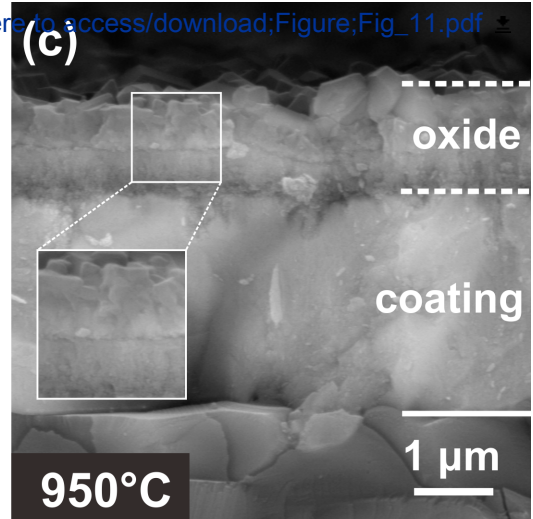
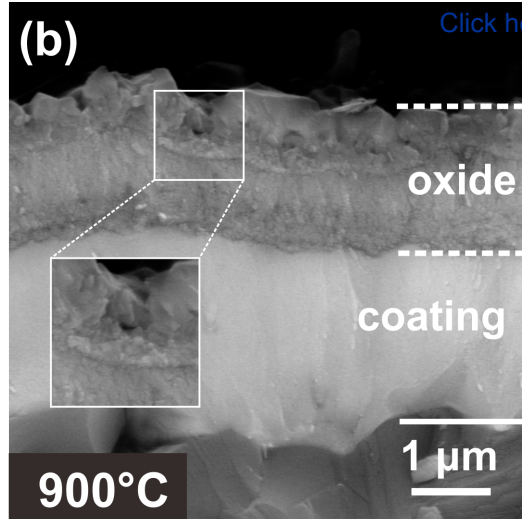
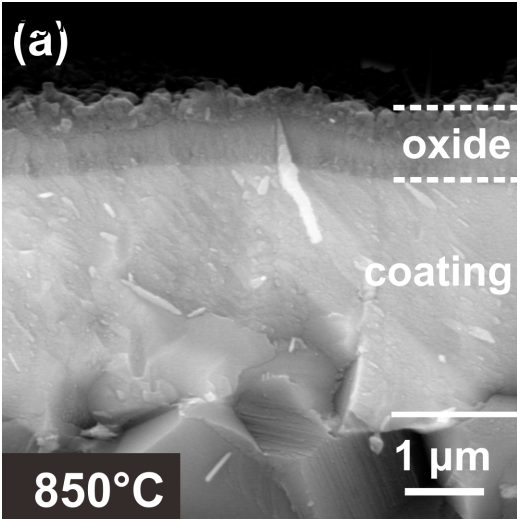
—■— c-TiN; —◆— w-AlN; —△— a-TiO₂; —▽— r-TiO₂; —◇— c-Al₂O₃; here to access/download;Figure;Fig_06.pdf













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Supplementary Material for on-line publication only
Supplementary data.pdf



Credit Author Statement:

Zhe R. Liu: Visualization, Writing- Original draft preparation. **Fei Pei:** Investigation. **Li Chen:** Conceptualization, Methodology, Writing - Review & Editing, and Funding acquisition. **Paul H. Mayrhofer:** Writing - Review & Editing.